

N-Channel PowerTrench[®] MOSFET 60 V, 22 A, 8.2 m Ω

Features

- \blacksquare Max $r_{DS(on)}$ = 8.2 m Ω at V_{GS} = 10 V, I_D = 13.5 A
- Max $r_{DS(on)}$ = 11.7 m Ω at V_{GS} = 4.5 V, I_D = 11.5 A
- Advanced package and silicon combination for low r_{DS(on)} and high efficiency
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

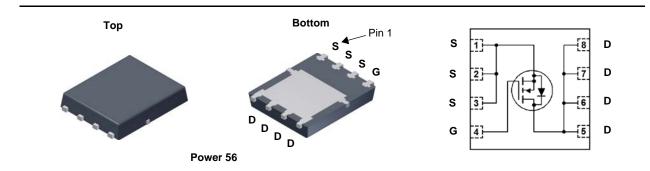


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(on)}$, fast switching speed and body diode reverse recovery performance.

Applications

- Primary Switch in isolated DC-DC
- Synchronous Rectifier
- Load Switch



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Param	eter		Ratings	Units	
V _{DS}	Drain to Source Voltage			60	V	
V _{GS}	Gate to Source Voltage			±20	V	
	Drain Current -Continuous	T _C = 25 °C		22		
I _D	-Continuous	T _A = 25 °C	(Note 1a)	13.5	Α	
	-Pulsed			60		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	91	mJ	
D	Power Dissipation	T _C = 25 °C		69	w	
P _D	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	vv	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	1.8	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	C/vv

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS86520L	FDMS86520L	Power 56	13 "	12 mm	3000 units

October 2014

Max	Units	
	V	
	mV/°C	
1	μA	
±100	nA	
3	V]
	mV/°C	
8.2		
11.7	mΩ	
11.8		
	S	
		-
4615	pF pF	
835	pF	
45	pF	

Ω

ns

ns

ns

ns

nC

nC

nC

nC

 ш
SWC
MS86520L N
20L
N-C
N-Channel F
nel F
Pow
erTr
werTrench
h® N
MOSF
FET
•

_ · J						
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 48 V, V_{GS} = 0 V$			1	
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 V, V_{DS} = 0 V$			±100	
On Chara	acteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$	1	1.8	3	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		-7		1
		V _{GS} = 10 V, I _D = 13.5 A		6.7	8.2	
r.	Static Drain to Source On Resistance	$V_{GS} = 4.5 V, I_D = 11.5 A$		9.1	11.7	
r _{DS(on)}		V _{GS} = 10 V, I _D = 13.5 A, T _J = 125 °C		9.6	11.8	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 13.5 A		51		
-	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		3470	4615	1
C _{oss}	Output Capacitance	$v_{DS} = 30 v, v_{GS} = 0 v,$ 		625	835	
C _{rss}	Reverse Transfer Capacitance			25	45	L
Rg	Gate Resistance			0.6		
Switchin	g Characteristics					
t _{d(on)}	Turn-On Delay Time			15	27	
t _r	Rise Time	V _{DD} = 30 V, I _D = 13.5 A,		5.6	11	
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		32	52	
t _f	Fall Time			3.4	10	
Qg	Total Gate Charge	$V_{GS} = 0 V \text{ to } 10 V$		45	63	
Qg	Total Gate Charge	$V_{GS} = 0$ V to 4.5 V $V_{DD} = 30$ V,		21	30	
Q _{gs}	Gate to Source Charge	I _D = 13.5 A		9.5		

Test Conditions

 $I_D = 250 \ \mu A$, referenced to 25 °C

 $I_D = 250 \ \mu\text{A}, \ V_{GS} = 0 \ V$

Min

60

Тур

29

Drain-Source Diode Characteristics

Gate to Drain "Miller" Charge

Electrical Characteristics T_J = 25 °C unless otherwise noted

Parameter

Drain to Source Breakdown Voltage

Breakdown Voltage Temperature

Symbol

 BV_{DSS}

 $\Delta T_{\rm J}$

 ΔBV_{DSS}

Off Characteristics

Coefficient

V _{SD}		$V_{GS} = 0 V, I_S = 2.1 A$ (Note 2)	0.72	1.2	V
		V _{GS} = 0 V, I _S = 13.5 A (Note 2)	0.83	1.3	v
t _{rr}	Reverse Recovery Time	I _F = 13.5 A, di/dt = 100 A/μs	37	60	ns
Q _{rr}	Reverse Recovery Charge	$F = 13.5 \text{ A}, \text{ u/ut} = 100 \text{ A/} \mu \text{s}$	21	34	nC
t _{rr}	Reverse Recovery Time	I _F = 13.5 A, di/dt = 300 A/μs	30	48	ns
Q _{rr}	Reverse Recovery Charge	$F = 13.5 \text{ A, u/u} = 300 \text{ A/}\mu\text{s}$	37	59	nC

Notes:

Q_{gd}

1. R_{0,JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.

minimum pad of 2 oz copper.

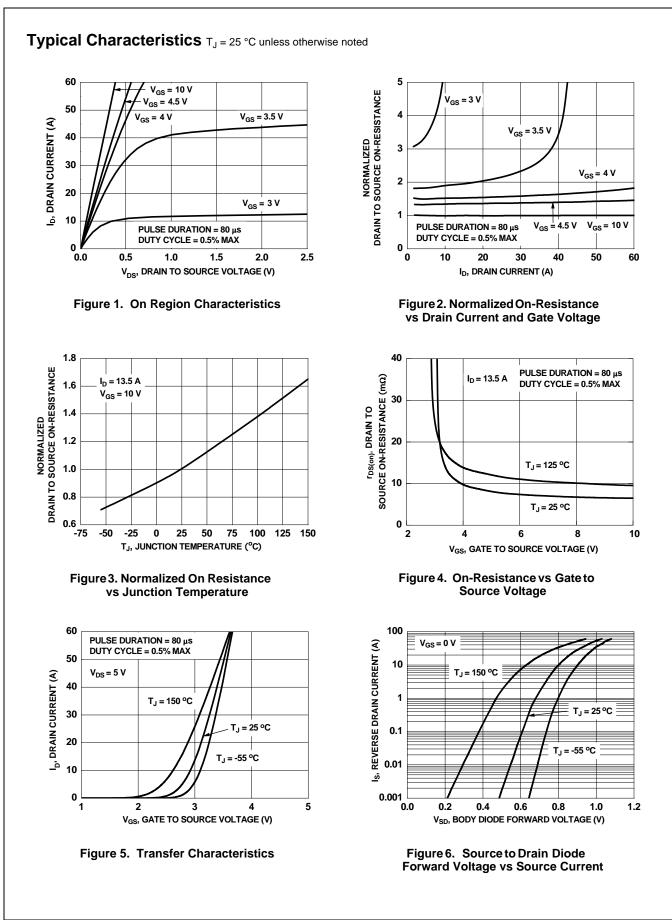
4.7

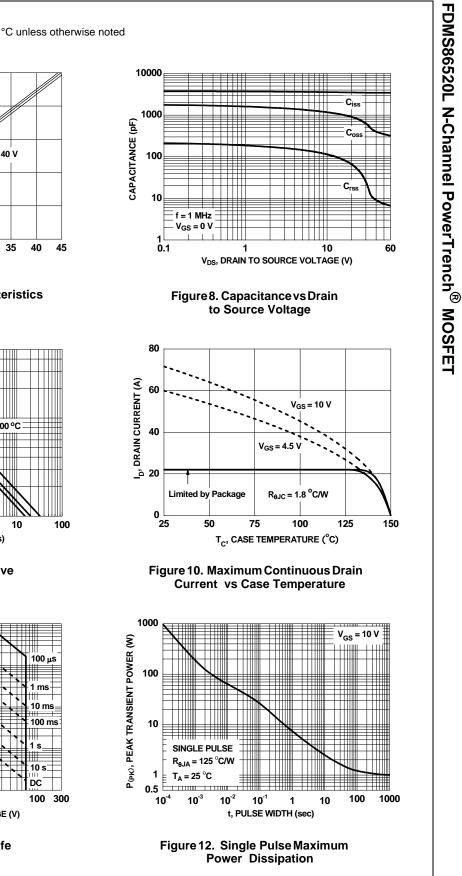
b. 125 °C/W when mounted on a



2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.

3. Starting T_J = 25 °C, L = 1 mH, I_{AS} = 13.5 A, V_{DD} = 54 V, V_{GS} = 10 V. 100% test at L = 0.1 mH, I_{AS} = 29 A.





Typical Characteristics $T_J = 25 \text{ °C}$ unless otherwise noted

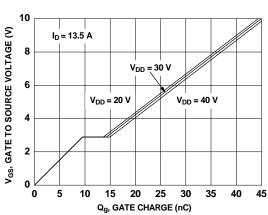
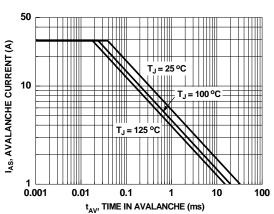
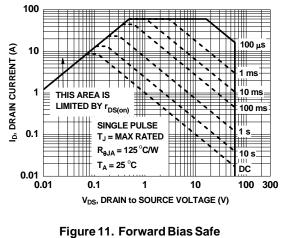


Figure 7. Gate Charge Characteristics

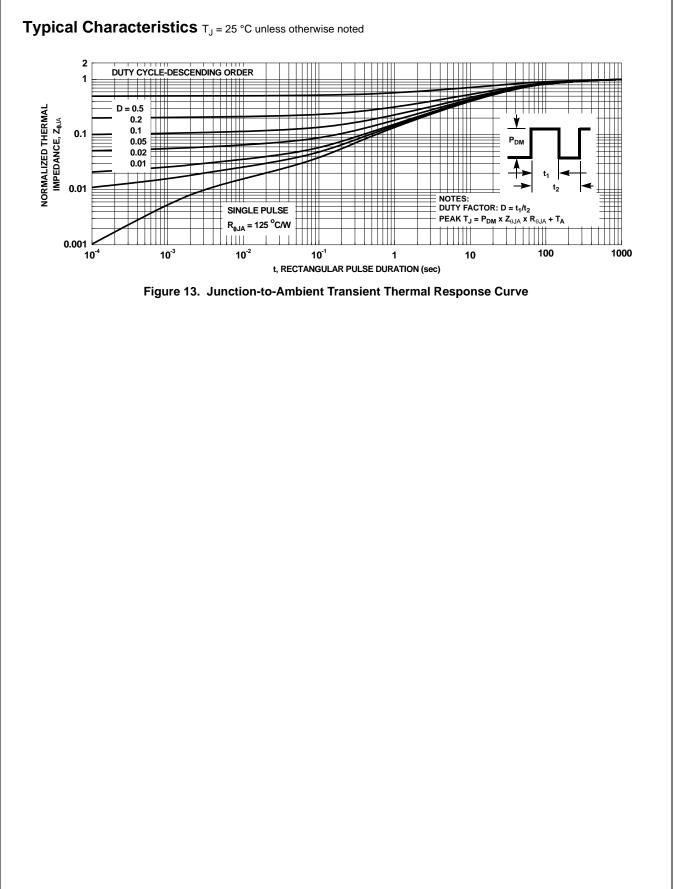






Operating Area

4





ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor has against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death ass

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

© Semiconductor Components Industries, LLC